Lecture 11

Clocking High-Performance Microprocessors

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Overview

- Readings (Actually for today's lecture)
 - GronowskiRestleHarrisAlpha clocking paperClock grid paperVariations paper
- Today's topics
 - Overview of clock distribution methods and challenges
 - · Three schemes of clock distribution
 - Overcoming and exploiting clock skew and jitter

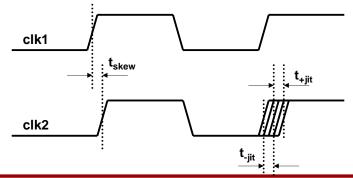
Latches and Flops Need Clocks

- Previous lecture on latches and flops assumed an input clock
 - We talked briefly about imperfections in that clock: skew, jitter
- In a chip, we can have *n* clocks for the latches and flops
 - n=1: one clock for the whole chip
 - n<10: one clock per major chip portion (e.g., core and cache)
 - 10<n<100: one clock per major functional block (e.g., GALS)
 - 100<n<10000: one clock per datapath stage
- This lecture will focus on the globally synchronous systems
 - One or a few clocks distributed across the chip
 - How do we do this, and why is it so hard?

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Principal Goal of Clock Distribution

- We need to distribute a stable clock across a die
 - Clock should be phase-aligned with an external input clock
 - Skew should be zero, or at least well-characterized
 - Jitter should be zero
 - Both skew and jitter should be insensitive to PVT
 - Duty cycle should be 50%-50%, or at least well-characterized



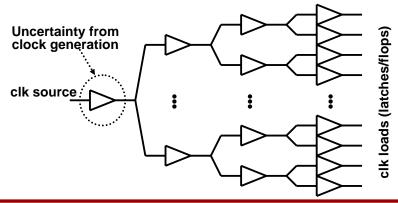
Other Goals of Clock Distribution

- Clock network should be low-power
 - But remember that most of the power is burned in the latches/flops
- Clock distribution should be simple to design and verify
- Clocking should allow external buses at slower frequencies
 - Bus/system clock is much slower than on-chip clock (why?)
 - Example: 533MHz bus clock, 3.0GHz chip clock
 - Often at a non-integer fraction of the CPU clock (3/5, 2/9...)
 - Every nth CPU clock is phase-aligned with every mth bus clock
- Clock generation should support test and debug
 - Control over frequency, skews, and duty cycle

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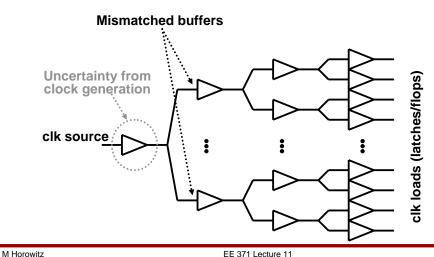
Principal Goal is Difficult

- Uncertainty in the clocking network appears everywhere!
 - Affects skew, jitter, and duty cycle of the delivered clock



Principal Goal is Difficult

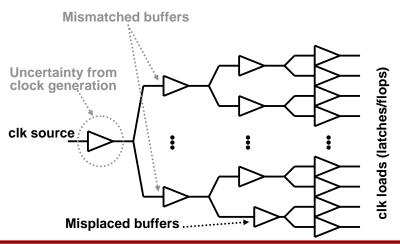
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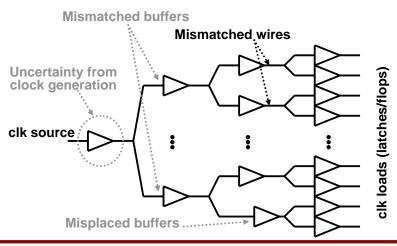
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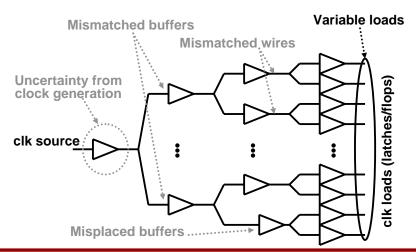
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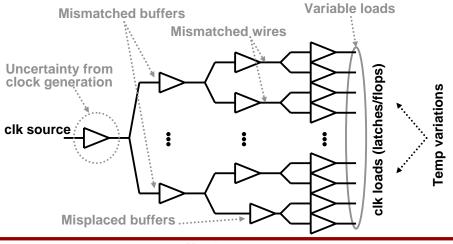
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Principal Goal is Difficult

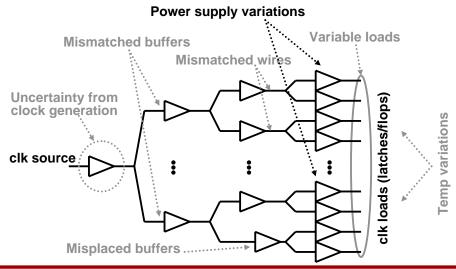
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Principal Goal is Difficult

- Uncertainty in the clocking network appears everywhere!
 - Affects skew, jitter, and duty cycle of the delivered clock



Mismatched Buffers

- Earlier we talked about process corners (FF, SS, TT, SF, etc.)
 - This represents variation from one die to another die
- There is also significant cross-die variation: "process tilt"
 - ITRS predicts 3σ of L_a will grow to be about 20% of L_a
 - Two devices on opposite chip sides will behave differently
 - Won't show up in process corners: all devices identically fast in FF
- There is also local systematic variation: "proximity effects"
 - Local wiring density affects etch rates and thus dimension control
 - Use dummy structures to equalize and match environments
- · Both process tilt and proximity effects must be considered

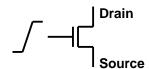
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Mismatched Wires and Misplaced Buffers

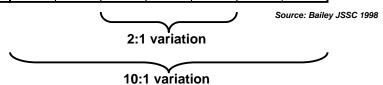
- We would prefer to put buffers in "exactly the right places"
 - But usually we cannot due to congestion (middle of the cache?)
 - Leads to mismatched wire loads
- Wires don't always fit "exactly right" either
 - They also have to fit in the middle of other layouts
 - You get different capacitive components (M5-M4, M5-M5, fringe...)
- But even if we put everything in the right places
 - (Expensive, but perhaps worth it for the clock)
 - Still have process tilt and proximity effects for wires
 - Again, not counted in process corner simulations
 - Designers often use shield wires and then ignore this

Variable Loads

- · Clocks drive latches and flops, which can be passgate loads
 - Load depends on the data going through the passgate



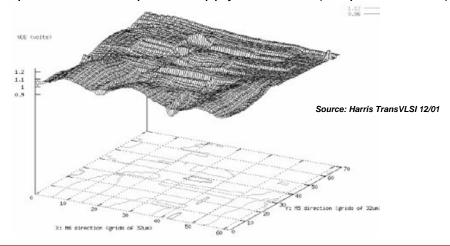
Drain	Fall	Fall	Low	High	High	High	Rise
Source	Fall	Low	Low	Low	High	Rise	Rise
Gate load	1.3x	1.1x	1.0	0.8x	0.42x	0.31x	0.13x



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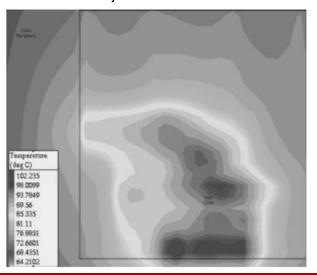
Power Supply Variations

- RTL-based power traces can drive a global grid simulation
- Example of Itanium II power supply variations (snapshot in time)



Temperature Variations

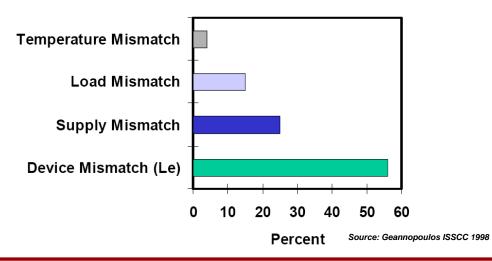
- Same for temperature variations, but these are slower effects
 - Long-term skew and/or jitter



M Horowitz EE 371 Lecture 11 Source: Harris TransVLSI 12/01

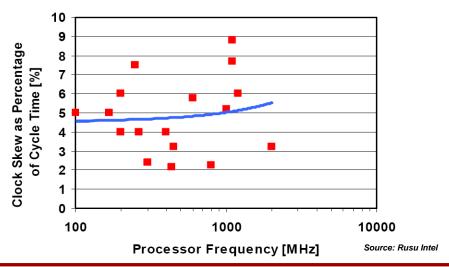
So What Makes Up Skew?

If we eliminate systematic offsets we care mostly about devices



How Much Skew Do We Have?

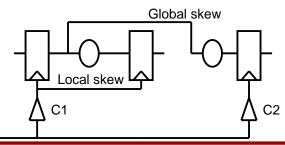
- Historically, skew budgets have been about 5% of the cycle time
 - What people generally try to hit in designs



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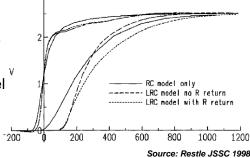
Simulating Skew

- Do not just gather all 3σ numbers in the worst possible way
 - Way too pessimistic; you'll never get the design done
 - You'll never see 3σ variation in clock buffers across a single datapath
- Statistical simulations figure out the "right" skew budget
 - Key point: skew from process variation affects **both** clock and data
 - · Data variation makes local skew budgets worse...
 - · ...but makes the difference in global and local skew smaller



Simulating Skew: A Note on Inductance

- Inductance doesn't matter for skinny signal wires
 - Short wires: driver resistance swamps out wire inductance
 - When $R_{driver} > 2Z_0$, where $Z_0 = \sqrt{\frac{R+j\omega L}{j\omega C}}$
 - Long wires: wire resistance swamps out wire inductance
 - When $R_{wire} > 2Z_0$ (*i.e.*, if attenuation factor $\alpha > 1$)
 - RLC models are exceedingly complicated and time-consuming
- But: model L for clock networks
 - Wires are wide (much less R_{wire})
 - We care about pS of skew
 - Only a few wires (100s) to model
- L noise also worth modeling



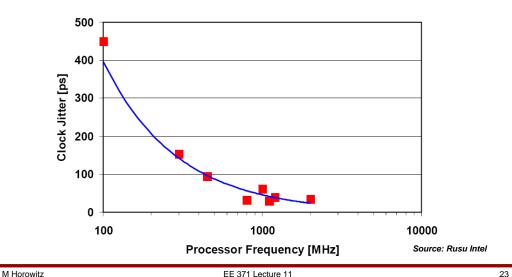
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What About Cycle-to-Cycle Variation (Jitter)?

- Jitter comes from temporal variations in the clock network
 - Some comes from the PLL/DLL, but not very much
 - Power supply changes mostly; temperature variations are slow
 - Also data coupling noise, but can design this away with shielding
- Jitter depends linearly on the delay through the clock network
 - "Insertion delay" is the time from PLL to the final latches
 - Around 2 cycles in CPUs today
- Note that jitter is primarily a max-path problem
 - Min-path problems are at the same clock edge
 - Although beware "differential jitter" between different clock nets

How Much Jitter Do We Have?

- Also around 5% of the cycle time (statistical simulations)
- But you should ask: how do people measure jitter? More later...

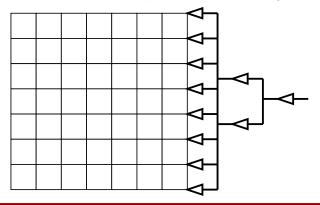


Clock Distribution Schemes

- Three principal ways of distributing clocks around a chip
 - Grid (DEC Alpha processors)
 - H-tree (IBM S/390, Intel Itanium)
 - Spines (Intel PentiumII, PentiumIII, P4)
 - Tree-Grid hybrids (IBM Power, Sun Ultrasparc)
- Other methods also being researched
 - Optical distribution
 - Resonant clocks

Clock Grids

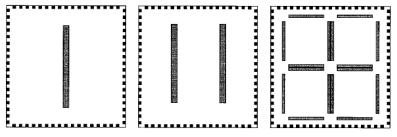
- Cover the entire chip with a grid that carries clock
 - Good: simple, low skew (because everything is shorted together)
 - Bad: lots of power and metal resources consumed
- · Need to figure out from where you will drive the grid



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Three Generations of Gridded Alphas

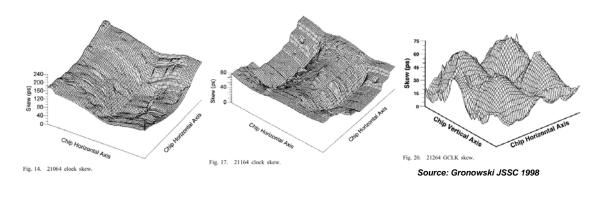
- · DEC Alpha used clock grids, driven by "panes" of drivers
 - 21064 (1993): 200MHz, 0.75µm process, one driver pane
 - 21164 (1996): 333MHz, 0.5μm process, two driver panes
 - 21264 (1997): 600MHz, 0.35μm process, sixteen driver panes



Source: Gronowski JSSC 1998

Alpha Gridded Skews

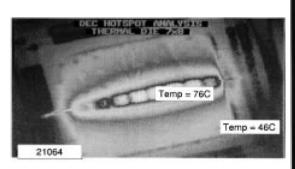
- Skews dropped: 240pS to 120pS to 75pS
 - As fraction of Tcycle: 4.8%, 3.6%, 4.5%
 - Simulated only, not measured

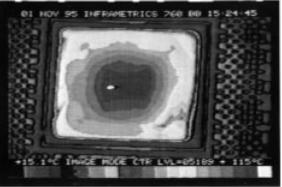


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Thermal Image of 21064 and 21164

- Single pane driver on 21064 was definitely a hotspot
 - Splitting into two panes reduced thermal gradients significantly

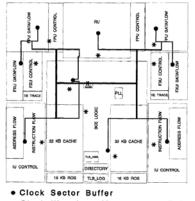


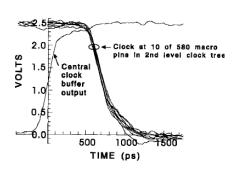


Source: Gronowski JSSC 1998

Clock H-Trees

- Balanced H-Trees are complex to design but are appealing
 - Good: Low power, low routing resources
 - Bad: Skew between divergent branches, complex design
- Example: IBM S/390 used balanced RC paths in the tree





Source: Webb JSSC 1997

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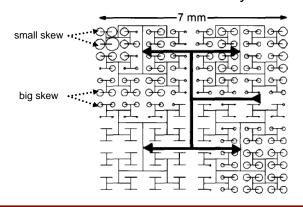
* Clock Waveform Measurement Point

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H-Trees and Points of Divergence

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- Skew between nodes on an H-Tree depends on location
 - Their last common node is their "Point of Divergence" (POD)
 - Two nodes with a near POD = low skew (10% s+j budget)
 - Two nodes with a far POD = high skew (20% s+j budget)
- Trees must balance RC delays with non-uniform loads

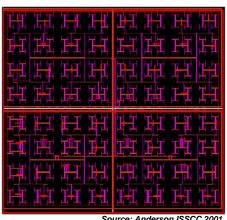


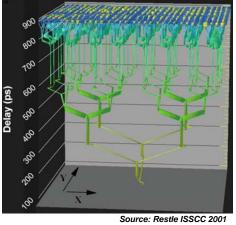
IBM testchip with loads shown by diameter

Source: Restle VLSI 2000

Hybrid: Trees Driving Grids

- Eliminates skew differences due to POD
 - But consumes lots of power, like grids
 - IBM Power4 in 0.18μm consumes 70% power in clocks and latches



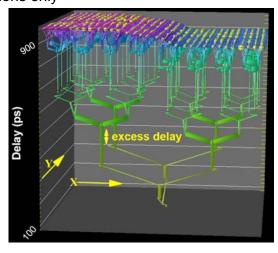


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Hybrid: Trees Driving Grids

- Simulations of skew-smoothing that you get with grids
 - IBM Power4 with intentional skew added to one buffer side
 - Simulations only



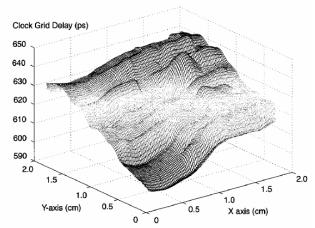
Animations of Grid Clocks

- Restle (IBM Research) does interesting work visualizing circuits
 - In particular, clock animations
 - http://researchweb.watson.ibm.com/people/r/restle/Animations/DAC01top.html

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Hybrid: Trees Driving Grids

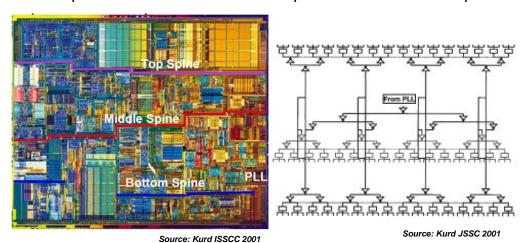
• Sun UltraSparcIII: balanced tree to global grid (skew simulated)



Source: Heald JSSC 2000

Clock Spines

- Spines look like a collapsed tree
 - Each spine is equipotential and can radiate outwards
- Example: First Intel Pentium4 microprocessor used three spines



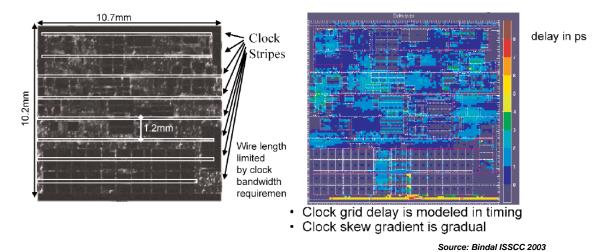
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Clock Spines Skew

Later Intel's 90nm P4 added more spines

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- Skew was simulated to be under 10pS

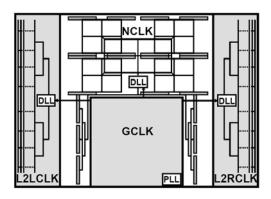


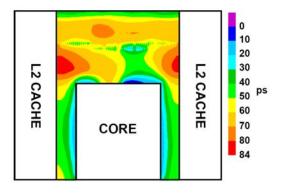
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A True Hybrid

- Compaq Alpha (EV8, r.i.p.)
 - Grid in core, panes and trees in memory/network, trees in cache
 - Skew in the "glue" memory/network controller < 90pS





Source: Xanthopoulos ISSCC 2001

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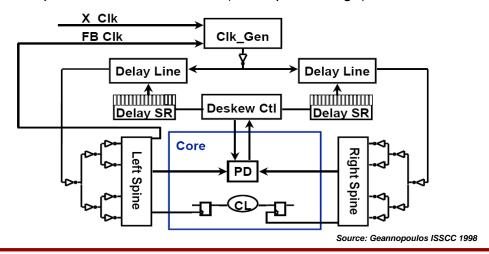
Minimizing Skew In Design

- Follow basic heuristics to match all gates
 - Single cell design with dummy structures around it, replicated
 - Same cell orientation in each instance
- Similar heuristics for wires
 - Consider and account for return path resistance
 - Heavily shield clock routes: makes C uniform and L minimal
 - Limit maximum wire dimensions: avoid skin effect
 - Simplify the problem by using templates
 - All of M5 looks like the following, repeated over the entire die



Active Skew Cancellation (Insertion)

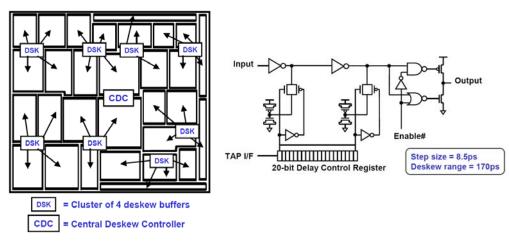
- · Look at clocks and adjust them
 - Need to be careful about the loop bandwidth and stability concerns
- Example from Intel PentiumIII (dual spine design)



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Multi-zone Deskew Circuits

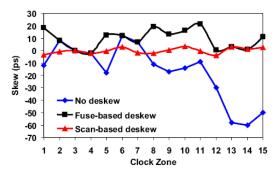
- Example from Intel Itanium clocking
 - Distribute an array of deskew buffers, each tying together 4 zones



Source: Rusu ISSCC 2000

Deskew Effectiveness

Chip	Publication	Zones	Skew	After	Stepsize
PentiumIII	ISSCC98	2	60pS	15pS	12pS
Itanium	ISSCC00	30	110pS	28pS	8pS
Pentium4	ISSCC01	47	64pS	16pS	8pS
Itanium (3 rd G)	ISSCC03	23	60pS	7pS	7pS



Worst case clock skew is 24ps in fuse mode and 7ps in scan mode

Source: Stinson ISSCC 2003

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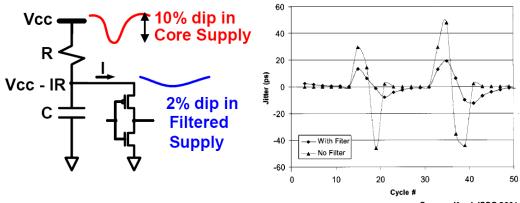
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Minimizing Jitter In Design

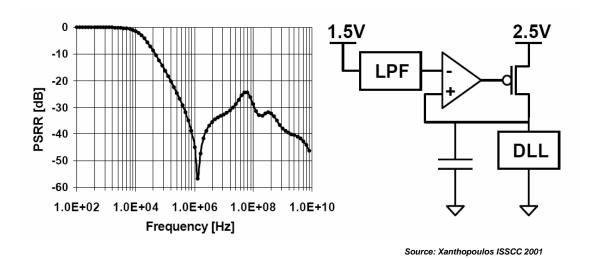
- Jitter predominantly comes from power supply noise
 - So filter the clock power supply
- Example from Pentium4 clock network (simulated)



Source: Kurd JSSC 2001 EE 371 Lecture 11

Minimizing Jitter In Design, con't

Compaq Alpha EV8 used essentially the same idea (simulated)



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Measuring Skew and Jitter

- There's a good reason why skew numbers are usually simulated
 - E-beam and picoprobe don't work with flip-chip packaging
- IBM PICA: Picosecond Imaging Circuit Analysis
 - Saturated nMOS emit photons in the channel
 - Very rarely; photons photomultiplied exponentially to be seen
 - Subsample to "probe" the whole chip at once over a long time
 - Can measure skew by imaging XOR of two different clocks
- Intel LVP: Laser Voltage Probe
 - Shine a laser onto the diffusion (from the back of the substrate)
 - Need a good transparent heat-spreader (diamond)
 - Reflectivity depends on voltage bias.
 - Probes only one point at a time, but rapidly

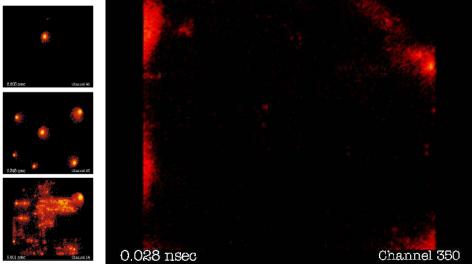
PICA Movie of Ring



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PICA Measurements

PICA measurements of S/390 clock shown

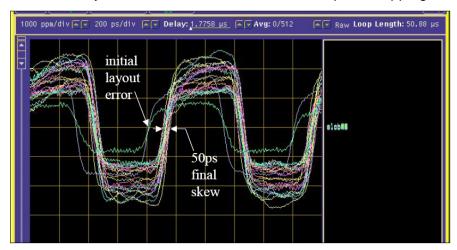


Source: Tsang IBM JourResDev 2000

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LVP Measurements of Skew

- Voltage levels not well characterized, but transitions are
 - Good for teasing out skew numbers from the edges
 - Shows a layout error that was fixed in a subsequent stepping



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Measuring Jitter

- Almost impossible to do, so everybody estimates it
 - You can try to measure total skew + jitter (Restle ISSCC 2005)
- Both PICA and LVP are averaging measurements (no jitter)
- Typical schemes drive a clock node to a pin to expose it
 - But need to buffer up to drive the pin
 - Ramp-up chain introduces jitter itself
- Measurement scopes have source jitter, too
 - Measured jitter: 150pS. Source trigger jitter: 150pS. Hmmm...
 - Commercial systems try to cancel trig jitter (M2, Wavecrest)
 - · But still end up with on-chip buffer jitter